

Dual N-channel 30 V, 5.1 mΩ standard level MOSFET

6 November 2013

Product data sheet

## 1. General description

Dual standard level N-channel MOSFET in an LFPAK56D (Dual Power-SO8) package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

## 2. Features and benefits

- Dual MOSFET
- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with  $V_{GS(th)}$  of greater than 1 V at 175  $^\circ\text{C}$

## 3. Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Transmission control
- Ultra high performance power switching

## 4. Quick reference data

| Table 1. Q        | uick reference data              |  |     |      |     |      |
|-------------------|----------------------------------|--|-----|------|-----|------|
| Symbol            | Parameter                        | Conditions   | Min | Тур  | Мах | Unit |
| V <sub>DS</sub>   | drain-source voltage             | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C  | -   | -    | 30  | V    |
| I <sub>D</sub>    | drain current                    | V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>   | -   | -    | 40  | А    |
| P <sub>tot</sub>  | total power dissipation          | T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>   | -   | -    | 68  | W    |
| Static chara      | cteristics FET1 and FET2         |  |     |      |     |      |
| R <sub>DSon</sub> | drain-source on-state resistance | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C;<br><u>Fig. 12</u>   | -   | 4.34 | 5.1 | mΩ   |
| Dynamic ch        | aracteristics FET1 and FE        | T2   |     |      |     |      |
| Q <sub>GD</sub>   | gate-drain charge                | $I_{D} = 10 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$<br>$T_{j} = 25 \text{ °C}; \underline{\text{Fig. 14}}; \underline{\text{Fig. 15}}$ | -   | 9    | -   | nC   |





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## 5. Pinning information

| Table 2. | Pinning | information |                               |                 |
|----------|---------|-------------|-------------------------------|-----------------|
| Pin      | Symbol  | Description | Simplified outline            | Graphic symbol  |
| 1        | S1      | source1     | 8 7 6 5                       | D1 D1 D2 D2     |
| 2        | G1      | gate1       |                               |                 |
| 3        | S2      | source2     | $\bigcirc$                    |                 |
| 4        | G2      | gate2       |                               |                 |
| 5        | D2      | drain2      |                               | <br>S1 G1 S2 G2 |
| 6        | D2      | drain2      |                               | mbk725          |
| 7        | D1      | drain1      | 1 2 3 4<br>LFPAK56D (SOT1205) |                 |
| 8        | D1      | drain1      | (0011200)                     |                 |

# 6. Ordering information

| Table 3.       Ordering information |          |  |         |  |  |  |
|-------------------------------------|----------|--|---------|--|--|--|
| Type number                         | Package  | ge   |         |  |  |  |
|                                     | Name     | Description  | Version |  |  |  |
| BUK7K5R1-30E                        | LFPAK56D | Plastic single ended surface mounted package (LFPAK56D); 8 leads | SOT1205 |  |  |  |

## 7. Marking

| Table 4. Marking codes |              |
|------------------------|--------------|
| Type number            | Marking code |
| BUK7K5R1-30E           | 75E130       |

## 8. Limiting values

#### Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol           | Parameter               | Conditions  | Min | Max           | Unit            |
|------------------|-------------------------|---|-----|---------------|-----------------|
| V <sub>DS</sub>  | drain-source voltage    | T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C                               | -   | 30            | V               |
| V <sub>DGR</sub> | drain-gate voltage      | $R_{GS}$ = 20 k $\Omega$ ; $T_j \ge 25 \text{ °C}$ ; $T_j \le 175 \text{ °C}$ | -   | 30            | V               |
| V <sub>GS</sub>  | gate-source voltage     | T <sub>j</sub> ≤ 175 °C; DC   | -20 | 20            | V               |
| I <sub>D</sub>   | drain current           | T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>                | -   | 40            | А               |
|                  |                         | T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>               | -   | 40            | А               |
| I <sub>DM</sub>  | peak drain current      | $T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4                        | -   | 340           | А               |
| P <sub>tot</sub> | total power dissipation | T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>  | -   | 68            | W               |
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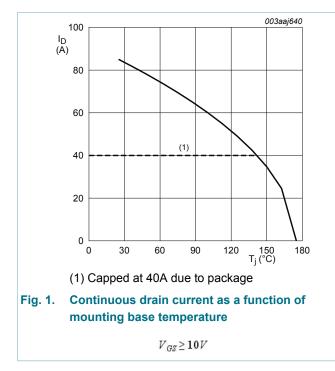
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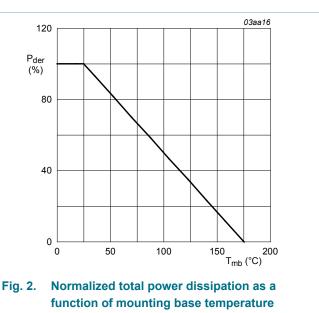
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| Symbol               | Parameter                                    | Conditions  |                | Min | Мах | Unit |
|----------------------|--|---|----------------|-----|-----|------|
| T <sub>stg</sub>     | storage temperature                          |   |                | -55 | 175 | °C   |
| Tj                   | junction temperature                         |   |                | -55 | 175 | °C   |
| $T_{sld(M)}$         | peak soldering temperature                   |   |                | -   | 260 | °C   |
| Source-drain         | diode FET1 and FET2                          |   |                | 1   | 1   |      |
| I <sub>S</sub>       | source current                               | T <sub>mb</sub> = 25 °C   |                | -   | 40  | А    |
| I <sub>SM</sub>      | peak source current                          | pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^\circ C$   |                | -   | 340 | А    |
| Avalanche Ru         | iggedness FET1 and FET2                      |   |                |     |     |      |
| E <sub>DS(AL)S</sub> | non-repetitive drain-source avalanche energy | $\begin{split} I_{D} &= 40 \text{ A};  \text{V}_{sup} \leq 30  \text{V};  \text{V}_{GS} = 10  \text{V}; \\ \text{T}_{j(\text{init})} &= 25 ^{\circ}\text{C};  \underline{\text{Fig. } 3} \end{split}$ | [ <u>1][2]</u> | -   | 228 | mJ   |

[1] Refer to application note AN10273 for further information

[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C

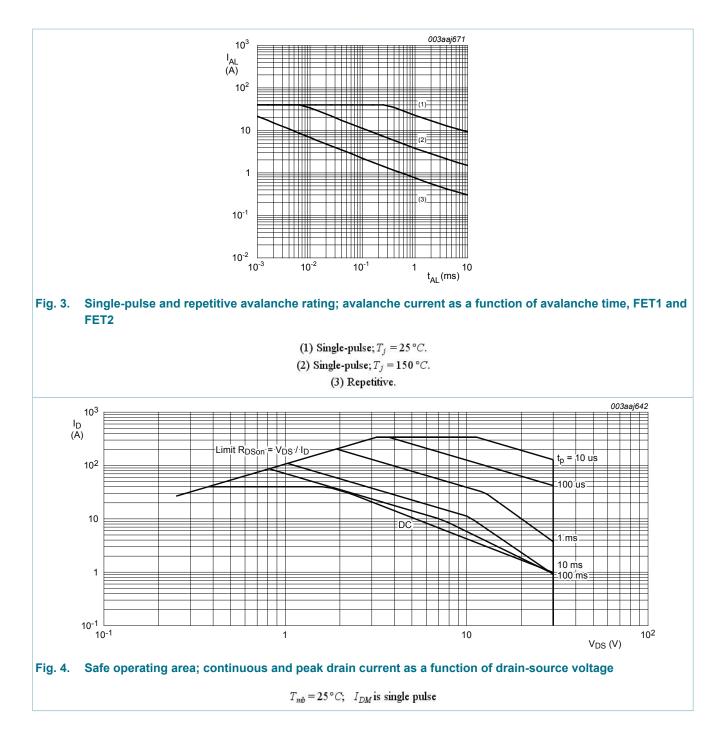




$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

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## 9. Thermal characteristics

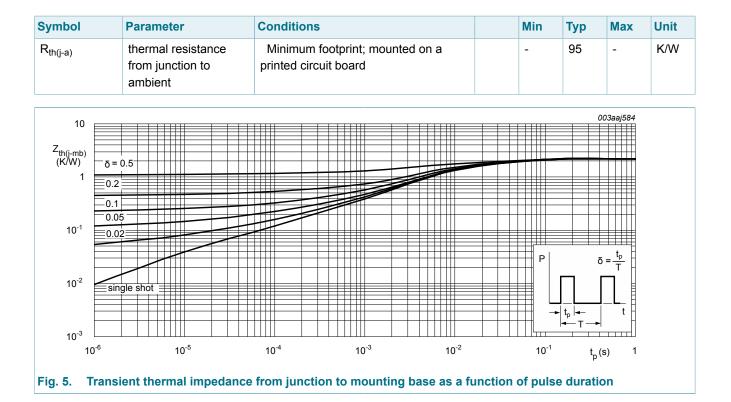
| Table 6. The          | rmal characteristics                                    |               |     |     |      |      |
|-----------------------|---|---------------|-----|-----|------|------|
| Symbol                | Parameter   | Conditions    | Min | Тур | Max  | Unit |
| R <sub>th(j-mb)</sub> | thermal resistance<br>from junction to<br>mounting base | Fig. <u>5</u> | -   | -   | 2.21 | K/W  |

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## **10. Characteristics**

| Symbol               | Parameter                        | Conditions  | Min | Тур  | Max | Unit |
|----------------------|----------------------------------|---|-----|------|-----|------|
| Static chara         | acteristics FET1 and FET2        | · · · · · · · · · · · · · · · · · · ·   |     |      |     |      |
| V <sub>(BR)DSS</sub> | drain-source                     | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C  | 27  | -    | -   | V    |
|                      | breakdown voltage                | $I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C   | 30  | -    | -   | V    |
|                      | gate-source threshold voltage    | $I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$<br>Fig. 10; Fig. 11                         | 2.4 | 3    | 4   | V    |
|                      |                                  | I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C;<br>Fig. 10; Fig. 11 | 1   | -    | -   | V    |
|                      |                                  | I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = -55 °C;<br>Fig. 10; Fig. 11 | -   | -    | 4.5 | V    |
| I <sub>DSS</sub>     | drain leakage current            | $V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C   | -   | -    | 500 | μA   |
|                      |                                  | $V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C  | -   | 0.02 | 1   | μA   |
| I <sub>GSS</sub>     | gate leakage current             | $V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C   | -   | 2    | 100 | nA   |
|                      |                                  | $V_{GS}$ = 20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C  | -   | 2    | 100 | nA   |
| R <sub>DSon</sub>    | drain-source on-state resistance | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C;<br>Fig. 12                       | -   | 4.34 | 5.1 | mΩ   |
|                      |                                  | V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C;<br>Fig. 12; Fig. 13             | -   | 7.6  | 9.4 | mΩ   |

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| Symbol              | Parameter                    | Conditions   | Min | Тур  | Max  | Unit |
|---------------------|------------------------------|--|-----|------|------|------|
| Dynamic cl          | naracteristics FET1 and FE   | ET2  | I   |      |      |      |
| Q <sub>G(tot)</sub> | total gate charge            | $I_D$ = 10 A; $V_{DS}$ = 24 V; $V_{GS}$ = 10 V;  | -   | 31.1 | -    | nC   |
| Q <sub>GS</sub>     | gate-source charge           | T <sub>j</sub> = 25 °C; <u>Fig. 14; Fig. 15</u>  | -   | 7.6  | -    | nC   |
| Q <sub>GD</sub>     | gate-drain charge            |  | -   | 9    | -    | nC   |
| C <sub>iss</sub>    | input capacitance            | V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz;<br>T <sub>j</sub> = 25 °C; <u>Fig. 16</u>  | -   | 1764 | 2352 | pF   |
| C <sub>oss</sub>    | output capacitance           |  | -   | 422  | 506  | pF   |
| C <sub>rss</sub>    | reverse transfer capacitance |  | -   | 242  | 332  | pF   |
| t <sub>d(on)</sub>  | turn-on delay time           | $\begin{split} V_{DS} &= 24 \text{ V}; \text{ R}_{L} = 2.4  \Omega; \text{ V}_{GS} = 10 \text{ V}; \\ \text{R}_{G(ext)} &= 5  \Omega; \text{ T}_{j} = 25 ^{\circ}\text{C}; \text{ I}_{D} = 10 \text{ A} \end{split}$ | -   | 9.5  | -    | ns   |
| t <sub>r</sub>      | rise time                    |  | -   | 12.5 | -    | ns   |
| t <sub>d(off)</sub> | turn-off delay time          |  | -   | 19.5 | -    | ns   |
| t <sub>f</sub>      | fall time                    | -  | -   | 13   | -    | ns   |
| Source-dra          | in diode FET1 and FET2       |  | I   |      |      |      |
| V <sub>SD</sub>     | source-drain voltage         | $I_{\rm S}$ = 10 A; $V_{\rm GS}$ = 0 V; $T_{\rm j}$ = 25 °C; Fig. 17   | -   | 0.78 | 1.2  | V    |
| t <sub>rr</sub>     | reverse recovery time        | $I_{S}$ = 10 A; d $I_{S}$ /dt = -100 A/µs; $V_{GS}$ = 0 V;   | -   | 27.4 | -    | ns   |
| Q <sub>r</sub>      | recovered charge             | V <sub>DS</sub> = 15 V; T <sub>j</sub> = 25 °C   | -   | 20.7 | -    | nC   |

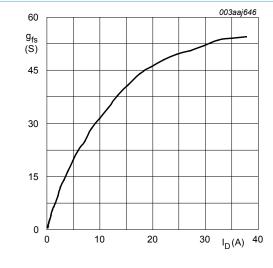
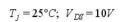


Fig. 6. Forward transconductance as a function of drain current; typical values



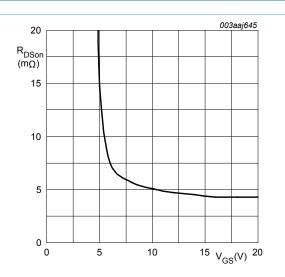
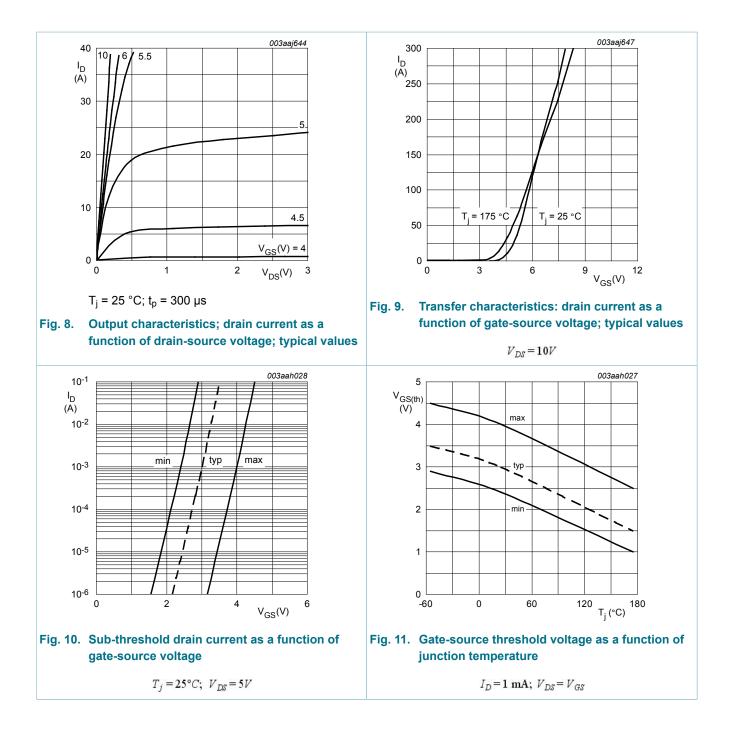


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_j = 25^{\circ}C; I_D = 10A$ 

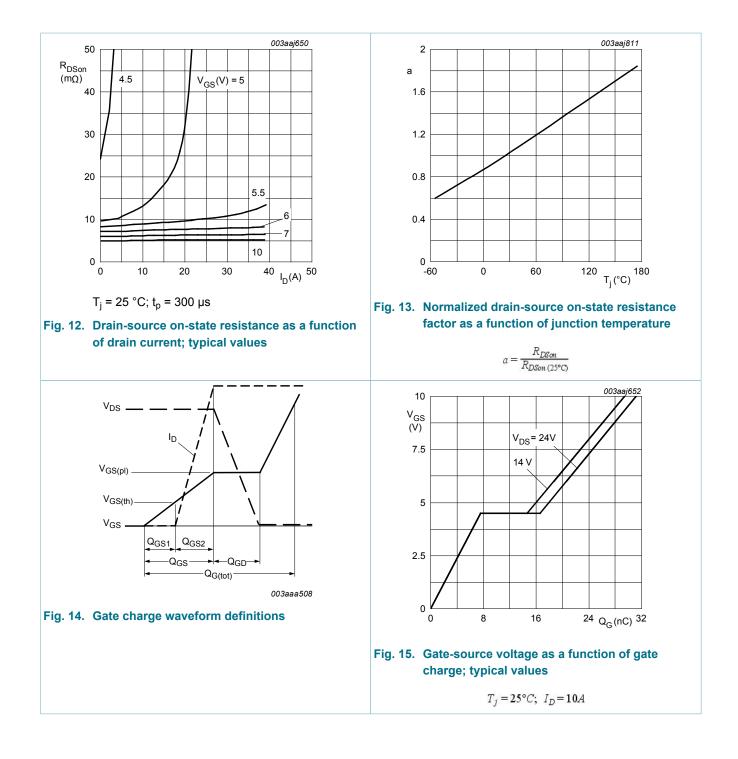
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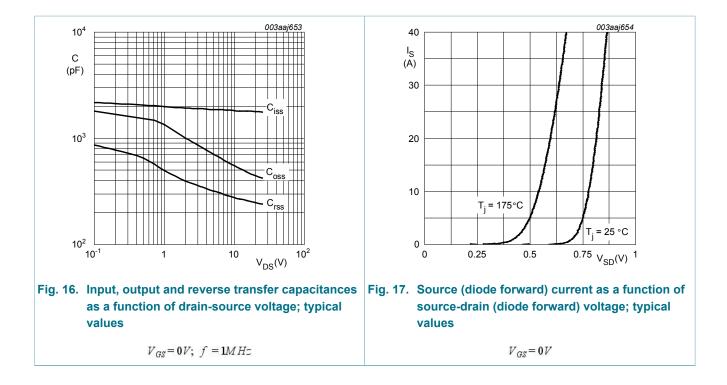
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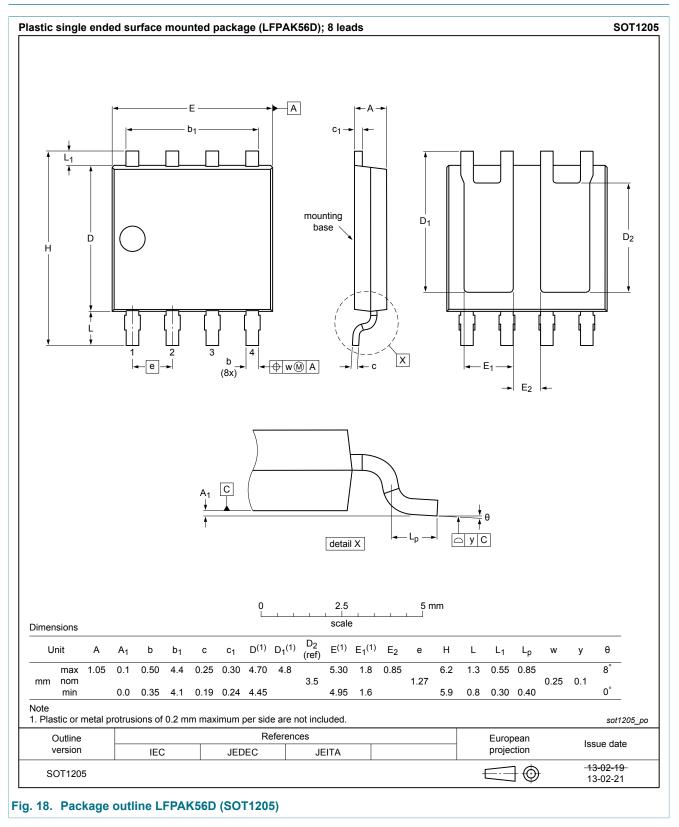


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## 11. Package outline



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Product data sheet

#### Dual N-channel 30 V, 5.1 mΩ standard level MOSFET

### 12. Legal information

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